

Search Notes

Application/Control No.

10/671,772

Examiner

EDMUND H. LEE

Applicant(s)/Patent under Reexamination

MORIYAMA ET AL.

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
264	248	3/15/2006	EHL
	250		
	254		
	255		
	279.1		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	3/15/2006	EHL
inventor		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner